

iMiD 2026

The 26th International Meeting on Information Display
August 18-21, 2026 / BEXCO, BUSAN, KOREA



Company Name	SEMILAB KOREA	Company Logo
Address	4F-412, 830, dongtansunhwan-daero, Hwaseong-si, Gyeonggi-do 18468,	
President	Younghoon Chung	
Website	https://semilab.com/en/	
E-mail	salesadmin.korea@semilab.com	
Telephone	031-630-2172	
Fax	031-630-2175	
Exhibitor Introduction	<p>SEMILAB is one of the key suppliers of metrology and inspection equipment for the display industry, based in Budapest, Hungary. We have R&D and product centers around the world, including the USA, Germany and China, and direct sales and service offices in all the major markets, including the USA, Japan, Korea, China, Taiwan and Singapore.</p> <p>Our customer-centric global support enables close collaboration with industry partners to understand and fulfill the requirements of the latest manufacturing and quality control processes of the microelectronics industry in order to serve customer satisfaction and enabling a smarter future</p>	
Exhibit Description	<p>SEMILAB provides state-of-the-art metrology solutions for semiconductor device manufacturers, both in-line and R&D segments, and is a strategic metrology supplier of leading wafer manufacturers, IC device makers in the More-than-Moore market segment, solar and display industries worldwide.</p> <p>We cover the entire R&D lifecycle of product innovation, ranging from innovative research, measurement development, product design and manufacturing to implementation, integration, and maintenance. With our 47 product lines and over 300 unique products, our growing portfolio</p>	

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	offers a variety of metrology solutions based on optical and electrical measurement technologies, thin film applications, and automation developments based on customer requirements, from manual operation to complete and factory scale automation
Exhibit Product	Spectroscopic Ellipsometry (SE) Spectroscopic Reflectometry (SR) Enhanced Infrared Reflectometry (FPT-EIR) Imaging Spectroscopic Reflectometry (iSR) Microwave Photoconductive Response(u-PCR) PL-based inspection for microLED (LumiPix) Four-point Probe